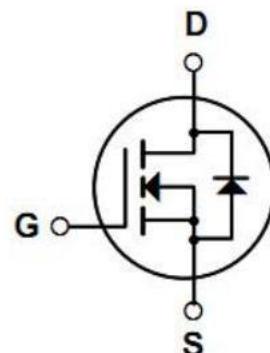


Description

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features

- 1) $V_{DS}=30V, I_D=5.8A, R_{DS(ON)}<41m\Omega @ V_{GS}=10V, R_{DS(ON)}<45m\Omega @ V_{GS}=4.5V, R_{DS(ON)}<59m\Omega @ V_{GS}=2.5V$.
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra $R_{DS(ON)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings $T_c=25^\circ C$, unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 12	V
I_D	Continuous Drain Current-	5.8	A
	Continuous Drain Current- $T_c=100^\circ C$	-	
	Pulsed Drain Current ¹	-	
E_{AS}	Single Pulse Avalanche Energy	--	mJ
P_D	Power Dissipation	1.4	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	-	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	89	

Package Marking and Ordering Information

Part NO.	Marking	Package
RYN30A6S	30A6S	SOT-23

Electrical Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	30	33		V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=30\text{V}$	-	-	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 12\text{V}, V_{\text{DS}}=0\text{A}$	-	-	± 100	nA
On Characteristics³						
$V_{\text{GS}(\text{th})}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	0.7	0.9	1.4	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On Resistance	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=5.8\text{A}$	-	28	41	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=5\text{A}$	-	31	45	
G_{FS}	Forward Transconductance	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=5\text{A}$	10	---	-	S
Dynamic Characteristics⁴						
C_{iss}	Input Capacitance	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	820	---	pF
C_{oss}	Output Capacitance		-	99	-	
C_{rss}	Reverse Transfer Capacitance		-	77	--	
R_g	Gate Resistance	f=1MHz	-	-	-	Ω
Switching Characteristics⁴						
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=15\text{V}, I_{\text{D}}=2.7\text{A}$	-	3.3	--	ns
t_r	Rise Time		-	4.8	---	ns
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time		-	26	---	ns
t_f	Fall Time		-	4	---	ns
Q_g	Total Gate Charge	$V_{\text{GS}}=4.5\text{V}, V_{\text{DS}}=15\text{V}, I_{\text{D}}=5.8\text{A}$	-	9.5	-	nC
Q_{gs}	Gate-Source Charge		-	15	-	nC
Q_{gd}	Gate-Drain "Miller" Charge		-	3	-	nC
Drain-Source Diode Characteristics						
V_{SD}	Source-Drain Diode Forward Voltage ³	$V_{\text{GS}}=0\text{V}, I_{\text{s}}=5.8\text{A}$	-	--	1.2	V
t_{rr}	Reverse Recovery Time	$I_{\text{F}}=15\text{A}, di/dt=10\text{A}/\mu\text{s}$	-	-	-	ns
Q_{rr}	Reverse Recovery Charge		-	-	-	nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production

Typical Electrical and Thermal Characteristics

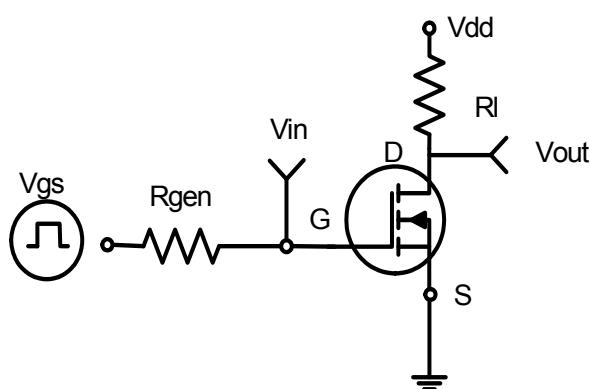


Figure 1:Switching Test Circuit

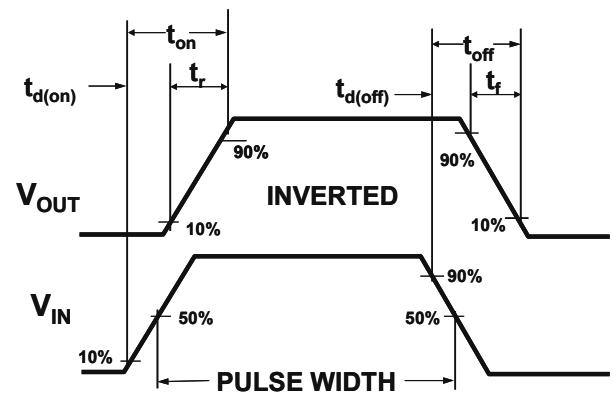


Figure 2:Switching Waveforms

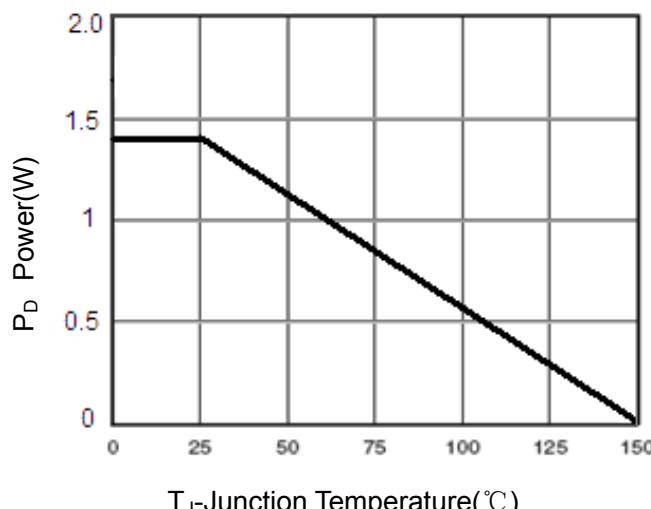


Figure 3 Power Dissipation

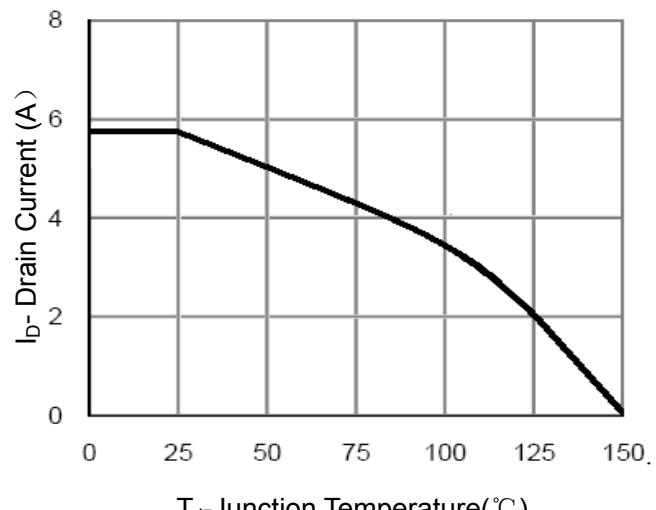


Figure 4 Drain Current

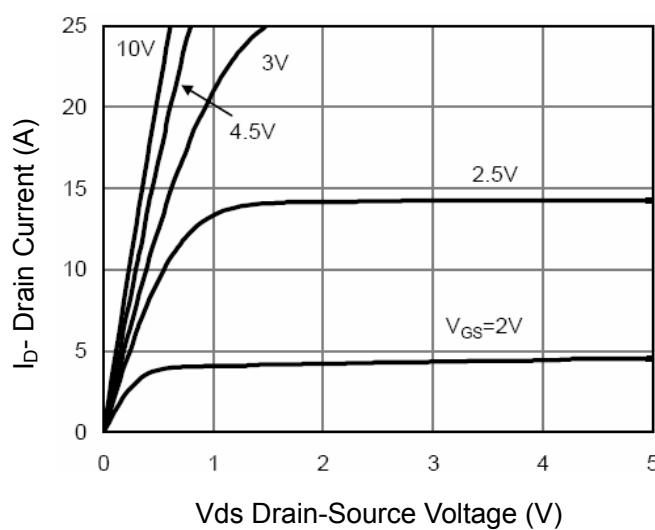


Figure 5 Output Characteristics

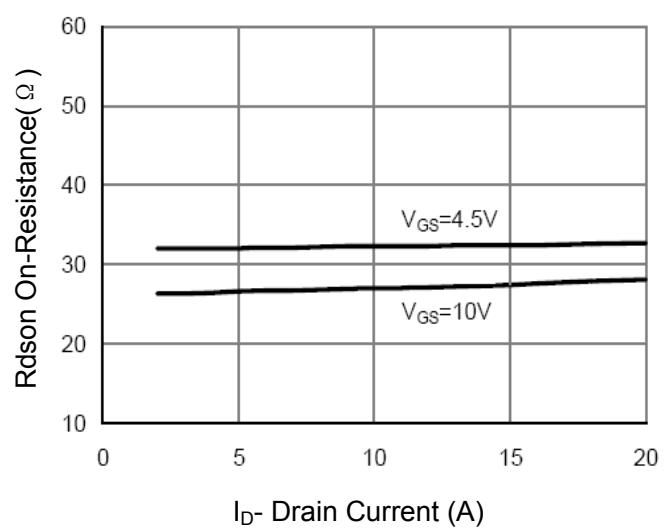
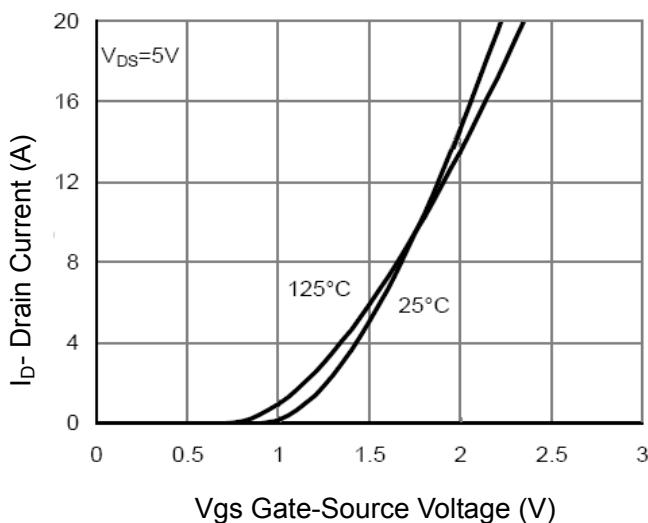
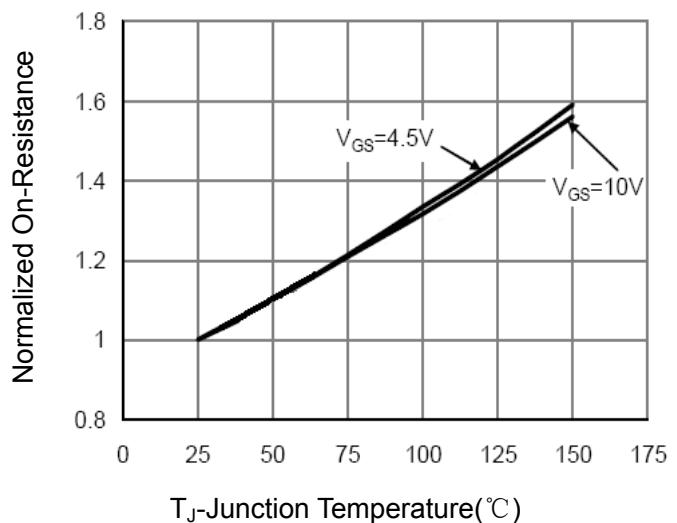
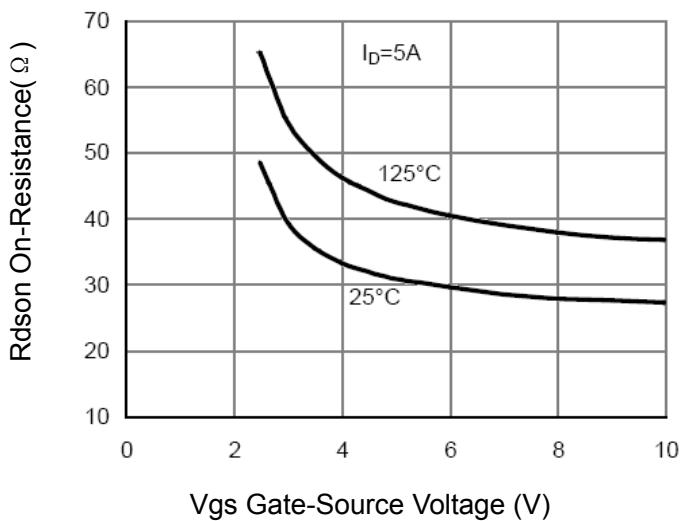
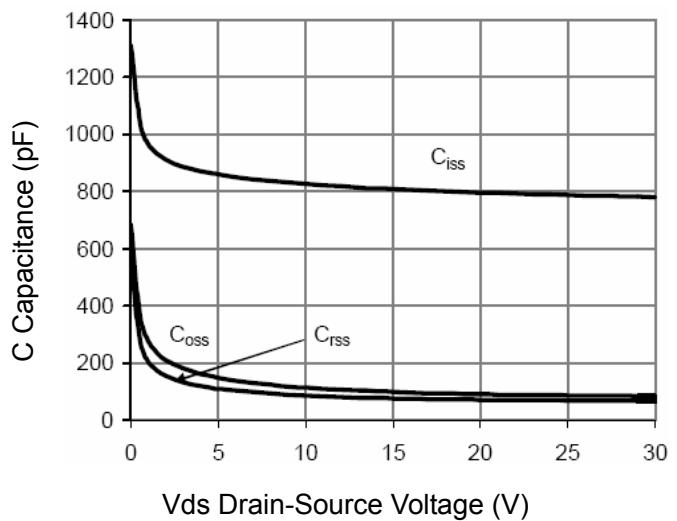
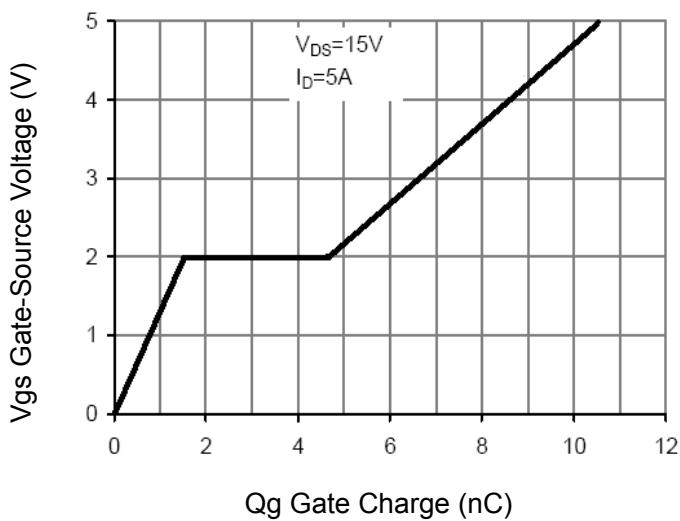
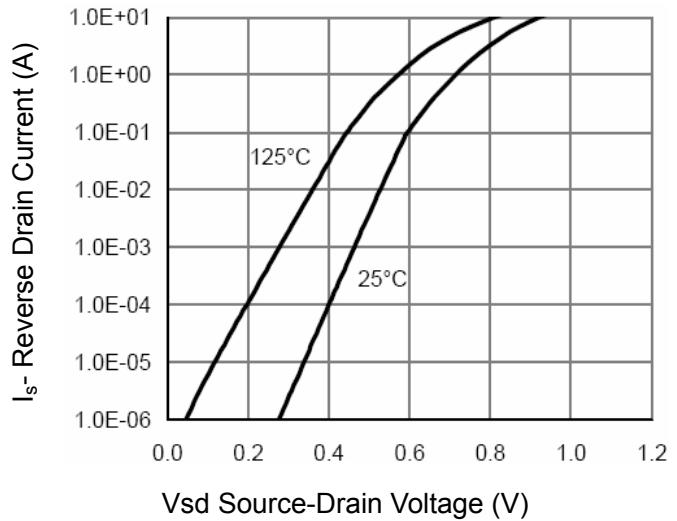
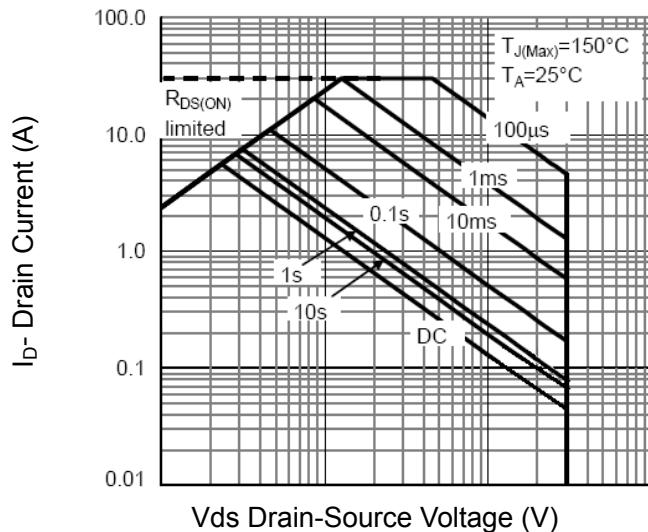
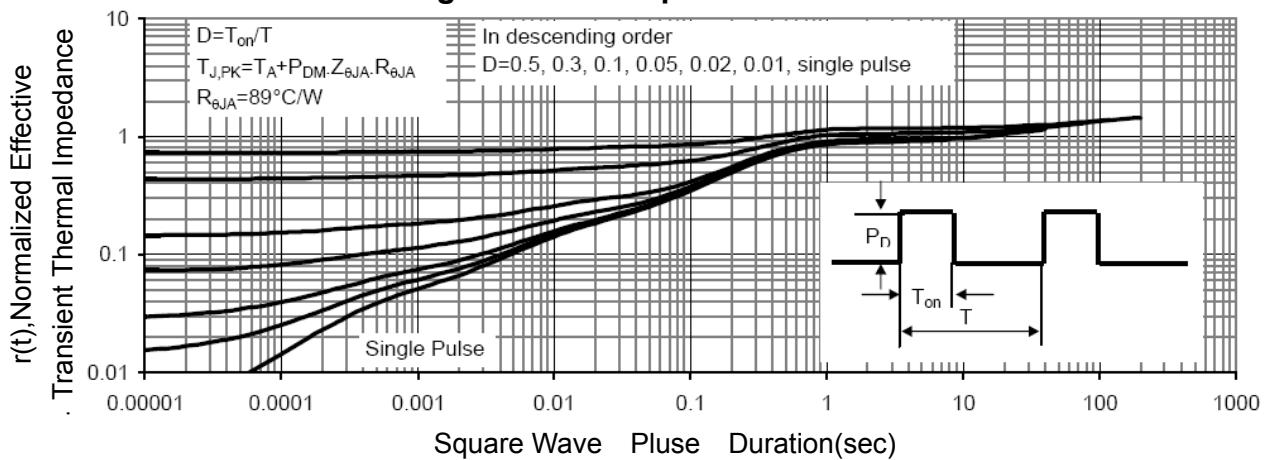


Figure 6 Drain-Source On-Resistance


Figure 7 Transfer Characteristics

Figure 8 Drain-Source On-Resistance

Figure 9 Rdson vs Vgs

Figure 10 Capacitance vs Vds

Figure 11 Gate Charge

Figure 12 Source- Drain Diode Forward

**Figure 13 Safe Operation Area****Figure 14 Normalized Maximum Transient Thermal Impedance**